

<b>Notice of References Cited</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination	
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	Examiner	Art Unit	Page 1 of 1
	Anabel M. Ton	2875	

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	C	US-6,511,195	01-2003	Marinacci, Angelo	362/43
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	M	US-			

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**NON-PATENT DOCUMENTS**

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